



N-Channel Enhancement Mode Field Effect Transistor

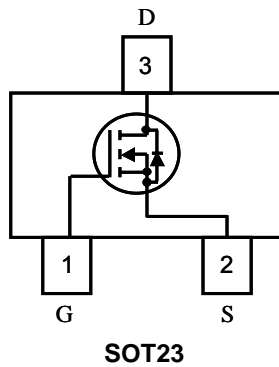
● Features

Advanced trench process technology
High-density cell design for ultra low on-resistance
Compact and low profile SOT23 package

● General Description

This N-Channel enhancement mode power FETs are produced with high cell density, DMOS trench technology, which is especially used to minimize on-state resistance. This device is particularly suited for low voltage application such as portable equipment, power management and other battery powered circuits, and low in-line power dissipation are needed in a very small outline surface mount package. Excellent thermal and electrical capabilities.

● Pin Configurations



● Absolute Maximum Ratings @T_A=25°C unless otherwise noted

| Parameter | Symbol | Ratings | Unit |
|--|-----------------------------------|-------------|------|
| Drain-Source Voltage | V _{DSS} | 200 | V |
| Gate-Source Voltage | V _{GSS} | ±20 | V |
| Drain Current ⁽¹⁾⁽²⁾ | I _D | Continuous | 2.0 |
| | | Pulsed | 6 |
| Power Dissipation | P _D | 150 | mW |
| Operating and Storage Junction Temperature Range | T _J , T _{STG} | -55 to +150 | °C |



● Electrical Characteristics @T_A=25°C unless otherwise noted

| Symbol | Parameter | Limit | Min | Typ | Max | Unit |
|----------------|---|---|-----|-----|------|------|
| STATIC | | | | | | |
| VDS | Drain-Source Breakdown Voltage | VGS=0V, ID=250μA | 200 | | | V |
| VGS(th) | Gate Threshold Voltage | VDS=VGS, ID=250μA | 1.0 | | 3.0 | V |
| IGSS | Gate Leakage Current | VDS=0V, VGS=±20V | | | ±100 | nA |
| IDSS | Zero Gate Voltage Drain Current | VDS=60V, VGS=0V | | | 1 | μA |
| RDS(ON) | Drain-Source On-Resistance ^a | VGS=10V, ID= 2.0A | | 520 | 580 | mΩ |
| | | VGS=4.5V, ID= 1.5A | | 650 | 800 | |
| VSD | Diode Forward Voltage | IS=1A, VGS=0V | | 0.8 | 1.2 | V |
| DYNAMIC | | | | | | |
| Qg | Total Gate Charge | VDS=30V, VGS=10V, ID=2.0A | | 12 | | nC |
| Qg | Total Gate Charge | VDS=30V, VGS=4.5V, ID=2.0A | | 6.5 | | |
| Qgs | Gate-Source Charge | | | 2.2 | | |
| Qgd | Gate-Drain Charge | | | 2.7 | | |
| Ciss | Input capacitance | VDS=30V, VGS=0V, f=1.0MHz | | 350 | | pF |
| Coss | Output Capacitance | | | 40 | | |
| Crss | Reverse Transfer Capacitance | | | 12 | | |
| Rg | Gate Resistance | VDS=0V, VGS=0V, f=1MHz | | 0.7 | | Ω |
| td(on) | Turn-On Delay Time | VDD=20V, RL =20Ω ID=1A, VGEN=10V RG=1Ω | | 10 | | ns |
| tr | Turn-On Rise Time | | | 11 | | |
| td(off) | Turn-Off Delay Time | | | 29 | | |
| tf | Turn-Off Fall Time | | | 3 | | |

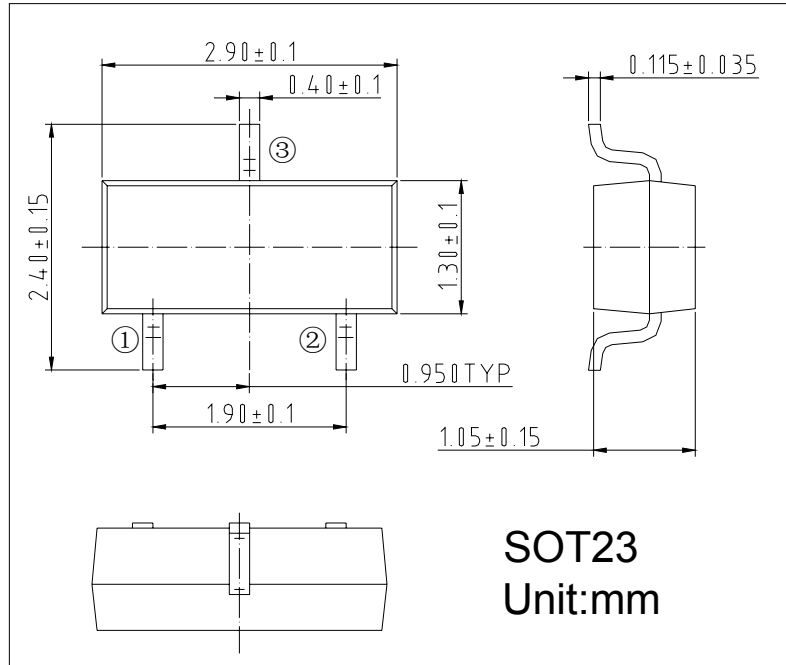
Notes :

(1).Pulse Test : Pulse Width < 300μs, Duty Cycle < 2%.

(2).Surface Mounted on FR4 Board, t < 10 sec.



● **Package Information**



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